

**Notice of References Cited**

Application/Control No.

10/559,659

Applicant(s)/Patent Under  
Reexamination  
KATO ET AL.

Examiner

HUY D. NGUYEN

Art Unit

2617

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2003/0058095 A1	03-2003	Satoh, Kazuhiko	340/509
*	B US-2003/0102872 A1	06-2003	Honda, Nobuaki	324/438
*	C US-2003/0216880 A1	11-2003	Endoh, Toshio	702/122
*	D US-2003/0214399 A1	11-2003	Naruse et al.	340/531
*	E US-2003/0229514 A2	12-2003	Brown, Stephen J	705/2
*	F US-6,710,326 B2	03-2004	Okamoto, Yasuhiro	250/221
*	G US-6,798,184 B2	09-2004	Honda, Nobuaki	324/71.5
*	H US-2007/0250410 A1	10-2007	Brignone et al.	705/028
*	I US-7,336,202 B2	02-2008	Kawai et al.	340/870.17
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
W	
X	

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